Search Notes

_	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/772,433	LEECH, MARCUS
	Examiner	Art Unit

Benjamin E. Lanier

2132

SEARCHED						
Class	Subclass	Date	Examiner			

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Limited Search of 380/28,29,37 See Attachment	4/5/2007	the
East Search See Attachment	4/5/2007	R
Inspec Search DESX	4/5/2007	R
Inventor Name Search Palm	4/5/2007	A
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